

## FDS7060N7

# 30V N-Channel PowerTrench® MOSFET

### **General Description**

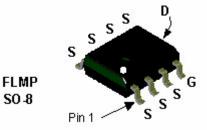
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{\text{DS(ON)}}$  in a small package.

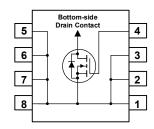
## **Applications**

- · Synchronous rectifier
- DC/DC converter

### **Features**

- 19 A, 30 V.  $R_{DS(ON)} = 5 \text{ m}\Omega \text{ @ } V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 7 \text{ m}\Omega \text{ @ } V_{GS} = 4.5 \text{ V}$
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- High power and current handling capability
- Fast switching, low gate charge (35nC typical)
- FLMP SO-8 package: Enhanced thermal performance in industry-standard package size





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		30	V
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	19	А
	– Pulsed		60	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	3.0	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	40	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	0.5	°C/W

**Package Marking and Ordering Information** 

Device Marking	Device	Reel Size	Tape width	Quantity
FDS7060N7	FDS7060N7	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	Durce Avalanche Ratings (Note	2)		<u> </u>		
E <sub>AS</sub>	Drain-Source Avalanche Energy	Single Pulse, V <sub>DD</sub> =30V, I <sub>D</sub> = 19A			360	mJ
I <sub>AS</sub>	Drain-Source Avalanche Current				19	Α
Off Char	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μА
I <sub>GSSF</sub>	Gate–Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate–Body Leakage, Reverse	V <sub>GS</sub> = -20 V V <sub>DS</sub> = 0 V			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.5	3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C		-4.7		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 16 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}, T_J = 125^{\circ}\text{C}$		4.0 5.8 6	5 7 6.5	mΩ
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V	60			Α
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 19 A		78		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V},  V_{GS} = 0 \text{ V},$		3274		pF
Coss	Output Capacitance	f = 1.0 MHz		721		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1		283		pF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V},  I_D = 1 \text{ A},$		11	20	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 5 \text{ V},  R_{GEN} = 6 \Omega$		8	16	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	7		60	96	ns
t <sub>f</sub>	Turn–Off Fall Time	7		30	48	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_{D} = 19 \text{ A},$		35	56	nC
Q <sub>gs</sub>	Gate–Source Charge	V <sub>GS</sub> = 5 V		10		nC
$Q_{gd}$	Gate-Drain Charge	7		12		nC

## **Electrical Characteristics**

T<sub>A</sub> = 25°C unless otherwise noted

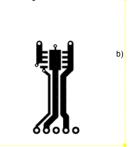
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Source Diode Characteristics and Maximum Ratings						
Is	Maximum Continuous Drain-Source Diode Forward Current				2.5	Α
$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 2.5 \text{ A}  \text{(Note 2)}$		0.7	1.2	V

#### Notes

1.  $R_{0JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0JC}$  is guaranteed by design while  $R_{0CA}$  is determined by the user's board design.



a) 40°C/W when mounted on a 1in² pad of 2 oz copper

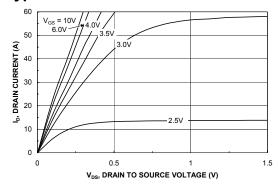


85°C/W when mounted on a minimum pad of 2 oz copper

Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

## **Typical Characteristics**



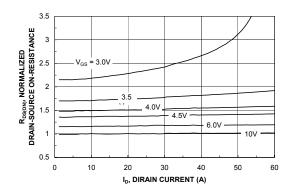
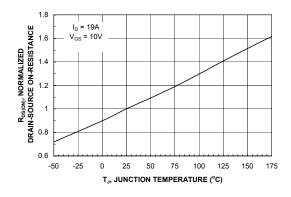


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



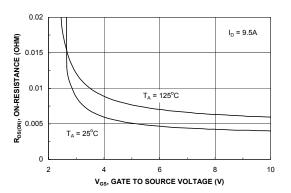
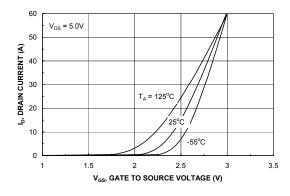


Figure 3. On-Resistance Variation withTemperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



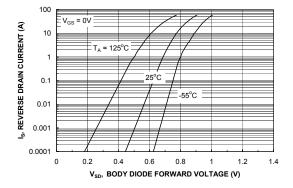
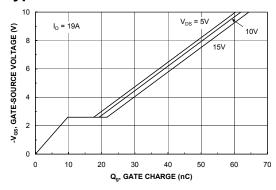


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



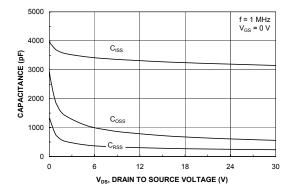
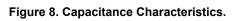
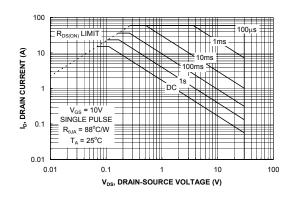


Figure 7. Gate Charge Characteristics.





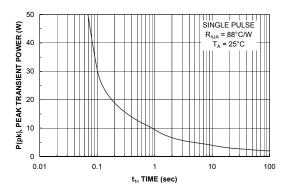


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

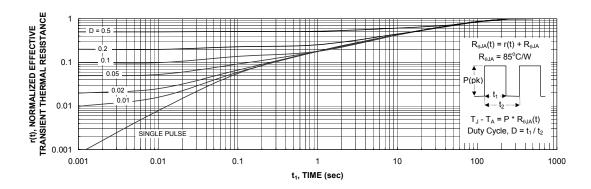
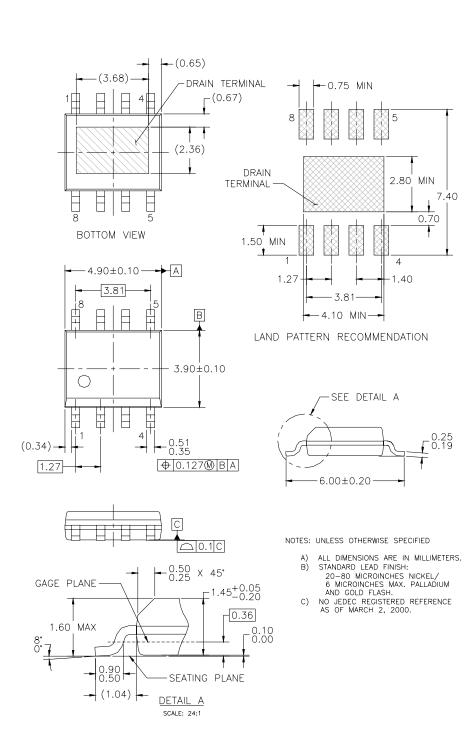


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

## **Dimensional Outline and Pad Layout**



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